TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74HC367AP,TC74HC367AF,TC74HC367AFN TC74HC368AP,TC74HC368AF,TC74HC368AFN

Hex Bus Buffer

TC74HC367AP/AF/AFN Non-Inverted (3-state)

TC74HC368AP/AF/AFN Inverted (3-state)

The TC74HC367A and TC74HC368A are high speed CMOS 3-STATE BUS BUFFERs fabricated with silicon gate C<sup>2</sup>MOS technology.

They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

They contain six buffers; four buffers are controlled by an enable input ( $\overline{G}1$ ), and the other two buffers are controlled by another enable input ( $\overline{G}2$ ). The outputs of each buffer group are enabled when  $\overline{G}1$  and/or  $\overline{G}2$  inputs are held low; if held high, these outputs are in a high impedance state.

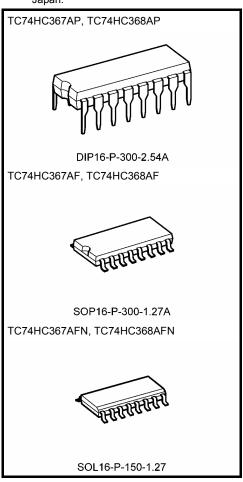
The TC74HC367A is a non-inverting output type, while the TC74HC368A is an inverting output type.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### **Features**

- High speed:  $t_{pd} = 11 \text{ ns (typ.)}$  at  $V_{CC} = 5 \text{ V}$
- Low power dissipation:  $I_{CC} = 4 \mu A \text{ (max)}$  at  $T_{a} = 25 \text{°C}$
- High noise immunity: V<sub>NIH</sub> = V<sub>NIL</sub> = 28% V<sub>CC</sub> (min)
- Output drive capability: 15 LSTTL loads
- Symmetrical output impedance:  $|I_{OH}| = I_{OL} = 6 \text{ mA}$
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: VCC (opr) = 2 to 6 V
- Pin and function compatible with 74LS367/368

Note: xxxFN (JEDEC SOP) is not available in Japan.

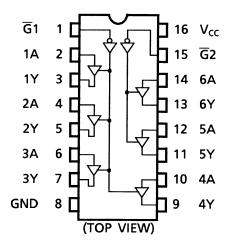


Weight

DIP16-P-300-2.54A : 1.00 g (typ.) SOP16-P-300-1.27A : 0.18 g (typ.) SOL16-P-150-1.27 : 0.13 g (typ.)

### **Pin Assignment**

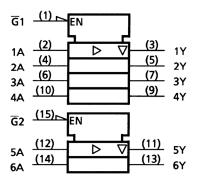
#### **TC74HC367A**



## **IEC Logic Symbol**

#### **TC74HC367A**

HEX BUS BUFFER (3 - STATE)



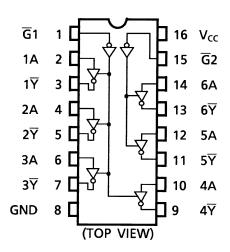
#### **Truth Table**

Inputs		Outputs					
G	An	Y (367A)	<u>Y</u> (368A)				
L	L	L	Н				
L	Н	Н	L				
Н	Х	Z	Z				

X: Don't care

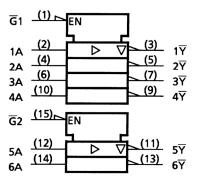
Z: High impedance

### **TC74HC368A**



### **TC74HC368A**

HEX BUS BUFFER (3 - STATE / INV.)





### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	$V_{CC}$	–0.5 to 7	V
DC input voltage	V <sub>IN</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
DC output voltage	V <sub>OUT</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>	±20	mA
Output diode current	lok	±20	mA
DC output current	lout	±35	mA
DC V <sub>CC</sub> /ground current	Icc	±75	mA
Power dissipation	PD	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	T <sub>stg</sub>	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of Ta = -40 to  $65^{\circ}C$ . From Ta = 65 to  $85^{\circ}C$  a derating factor of -10 mW/°C shall be applied until 300 mW.

## **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	2 to 6	V
Input voltage	V <sub>IN</sub>	0 to V <sub>CC</sub>	٧
Output voltage	V <sub>OUT</sub>	0 to V <sub>CC</sub>	٧
Operating temperature	T <sub>opr</sub>	−40 to 85	°C
		0 to 1000 (V <sub>CC</sub> = 2.0 V)	
Input rise and fall time	t <sub>r</sub> , t <sub>f</sub>	0 to 500 (V <sub>CC</sub> = 4.5 V)	ns
		0 to 400 (V <sub>CC</sub> = 6.0 V)	

Note: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either VCC or GND.



## **Electrical Characteristics**

## **DC Characteristics**

Characteristics	Symbol	Test Condition  V <sub>CC</sub> (V)		Ta = 25°C			Ta = -40 to 85°C		Unit	
					Min	Тур.	Max	Min	Max	01
		_		2.0	1.50	_	_	1.50	_	
High-level input voltage	$V_{IH}$			4.5	3.15	_	_	3.15	_	V
				6.0	4.20			4.20	_	
				2.0	_	_	0.50	_	0.50	
Low-level input voltage	$V_{IL}$	_		4.5	_	_	1.35	_	1.35	V
				6.0	_		1.80		1.80	
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>		2.0	1.9	2.0	_	1.9	_	
	V <sub>OH</sub>		I <sub>OH</sub> = -20 μA	4.5	4.4	4.5	_	4.4	_	
High-level output voltage				6.0	5.9	6.0	_	5.9	_	V
			$I_{OH} = -6 \text{ mA}$	4.5	4.18	4.31	_	4.13	_	
			$I_{OH} = -7.8 \text{ mA}$	6.0	5.68	5.80		5.63	_	
	V <sub>OL</sub>	VIN = VIH or VI L	I <sub>OL</sub> = 20 μA	2.0	_	0.0	0.1	_	0.1	٧
				4.5	_	0.0	0.1	_	0.1	
Low-level output voltage				6.0	_	0.0	0.1		0.1	
Ü			I <sub>OL</sub> = 6 mA	4.5	_	0.17	0.26	_	0.33	
			I <sub>OL</sub> = 7.8 mA	6.0	_	0.18	0.26		0.33	
3-state output off-state current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND		6.0	_	_	±0.5	_	±5.0	μА
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	_	_	±0.1		±1.0	μА
Quiescent supply current	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	_	_	4.0	_	40.0	μА



AC Characteristics (input:  $t_r = t_f = 6$  ns)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
Sharasteristics Symbol			CL (pF)	V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Offic
	4			2.0	_	25	60	_	75	
Output transition time	t <sub>TLH</sub>	_	50	4.5	_	7	12	_	15	ns
	t <sub>THL</sub>			6.0	_	6	10	_	13	
				2.0	_	36	95	_	120	
			50	4.5	_	12	19	_	24	
Propagation delay	$t_{pLH}$			6.0	_	10	16	_	20	
time	$t_{pHL}$	_		2.0	_	40	130	_	165	ns
			150	4.5	_	16	26	_	33	
				6.0	_	14	22	_	28	
	t <sub>pZL</sub> t <sub>pZH</sub>	$R_L = 1 \text{ k}\Omega$	50	2.0	_	36	120	_	150	- ns
				4.5	_	12	24	_	30	
Output anabla tima				6.0	_	10	20	_	26	
Output enable time			150	2.0	_	40	160	_	200	
				4.5	_	16	32	_	40	
				6.0	_	14	27	_	34	
	t <sub>pLZ</sub>	$R_L = 1 \text{ k}\Omega$	50	2.0	_	35	120	_	150	ns
Output disable time				4.5	_	15	24	_	30	
				6.0	_	13	20	_	26	
Input capacitance	C <sub>IN</sub>	_			_	5	10	_	10	pF
Output capacitance	C <sub>OUT</sub>	_			_	10	_	_	_	pF
Power dissipation capacitance	C <sub>PD</sub>	TC74HC367A			_	36	_	_	_	
	(Note)	TC74HC368A			_	30	_	_	_	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

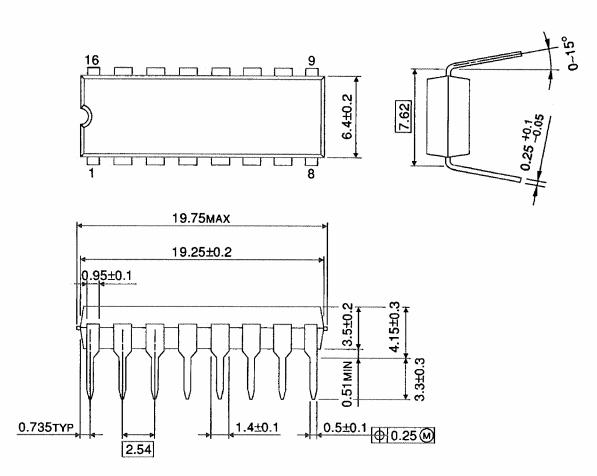
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Average operating current can be obtained by the equation:

$$I_{CC}$$
 (opr) =  $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/6$  (per bit)

# **Package Dimensions**

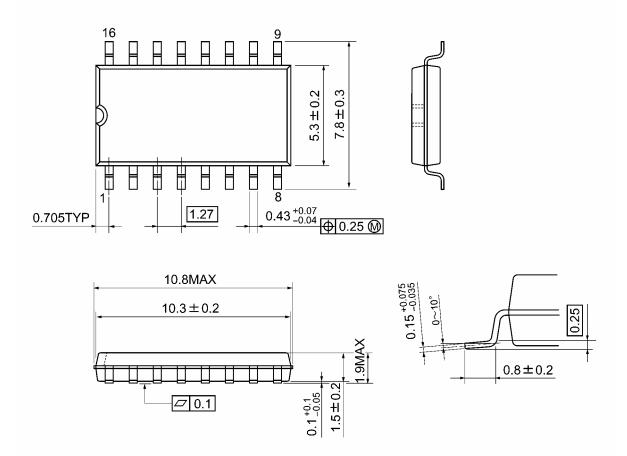
DIP16-P-300-2.54A Unit: mm



Weight: 1.00 g (typ.)

# **Package Dimensions**

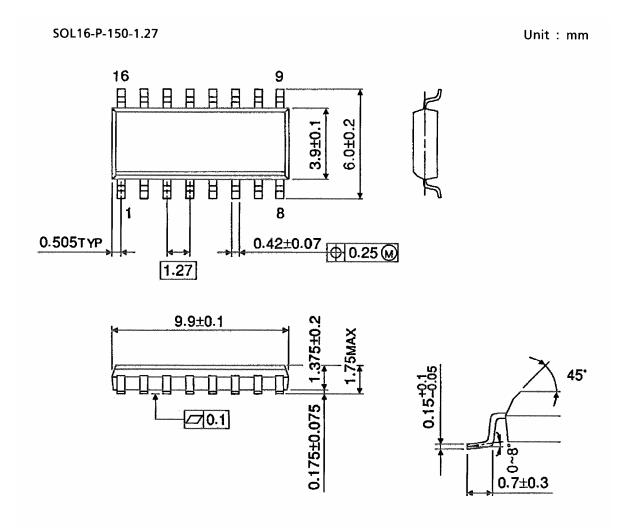
SOP16-P-300-1.27A Unit: mm



Weight: 0.18 g (typ.)



# **Package Dimensions (Note)**



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Note: This package is not available in Japan.

Weight: 0.13 g (typ.)

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20070701-EN GENERAL

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